

INFORMATION DISCLOSURE CITATION

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ATTY. DOCKET NO.
44046.203.187.1SERIAL NO.
10/071,420APPLICANT
Valek, et al.FILING
February 8, 2002GROUP
3723

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DVN	5,153,054 /	10/06/92	Depauw, et al.	428	216	12/28/89

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

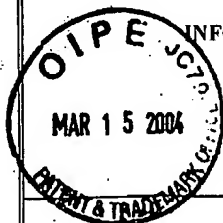
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DVN	5,873,203 /	02/23/99	Thiel	52	172	
	5,227,206 /	07/13/93	Bachli	428	34	
	4,587,769 /	05/13/86	Cathers	51	165/87	
	2,781,561 /	02/26/53	Gifford, et al.	20	69	
	2,723,427 /	11/15/55	Bobel	20	56.4	
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
DVN	EP 1 182 174 A1 /	02/27/02	Europe	C03C	17/23		
DVN	WO 00/43711 /	07/27/00	PCT	F21V	9/04		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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